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June 2015

## **FDZ1416NZ**

## Common Drain N-Channel 2.5 V PowerTrench® WL-CSP MOSFET

## 24 V, 7 A, 23 mΩ

#### **Features**

- Max  $r_{S1S2(on)} = 23 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_{S1S2} = 1 \text{ A}$
- Max  $r_{S1S2(on)} = 25 \text{ m}\Omega$  at  $V_{GS} = 4 \text{ V}$ ,  $I_{S1S2} = 1 \text{ A}$
- Max  $r_{S1S2(on)} = 28 \text{ m}\Omega$  at  $V_{GS} = 3.1 \text{ V}$ ,  $I_{S1S2} = 1 \text{ A}$
- Max  $r_{S1S2(on)} = 33 \text{ m}\Omega$  at  $V_{GS} = 2.5 \text{ V}$ ,  $I_{S1S2} = 1 \text{ A}$
- Occupies only 2.2 mm<sup>2</sup> of PCB area
- Ultra-thin package: less than 0.35 mm height when mounted to PCB
- High power and current handling capability
- HBM ESD protection level > 3.2 kV (Note 3)
- RoHS Compliant

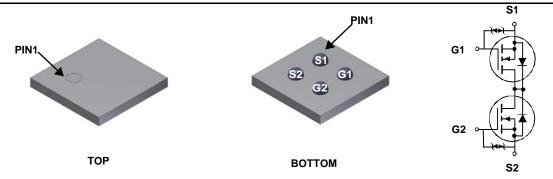


#### **General Description**

This device is designed specifically as a single package solution for Li-lon battery pack protection circuit and other ultra-portable applications. It features two common drain N-channel MOSFETs, which enables bidirectional current flow, on Fairchild's advanced PowerTrench process with state of the art "low pitch" WLCSP packaging process, the FDZ1416NZ minimizes both PCB space and  $r_{\rm S1S2(on)}.$  This advanced WLCSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge and low  $r_{\rm S1S2(on)}.$ 

## **Applications**

- Battery management
- Load switch
- Battery protection



WL-CSP 1.4X1.6

## MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Paramete		Ratings	Units		
V <sub>S1S2</sub>	Source1 to Source2 Voltage	24	V			
V <sub>GS</sub>	Gate to Source Voltage		±12	V		
1	Source1 to Source2 Current -Continuous	T <sub>A</sub> = 25°C	(Note 1a)	7	Δ.	
I <sub>S1S2</sub>	-Pulsed		30	A		
D	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	1.7	10/	
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1b)	0.5	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperatu	-55 to +150	°C			

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	74	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	230	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
EN	FDZ1416NZ	WL-CSP 1.4X1.6	7 "	8 mm	5000 units

## **Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Characteristics							
I <sub>S1S2</sub>	Zero Gate Voltage Source1 to Source2 Current	V <sub>S1S2</sub> = 19 V, V <sub>GS</sub> = 0 V			1	μА	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±12 V, V <sub>S1S2</sub> = 0 V			±10	μΑ	

#### **On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{S1S2}, I_{S1S2} = 250 \mu A$	0.4	0.9	1.3	V	
r <sub>S1S2(on)</sub>		V <sub>GS</sub> = 4.5 V, I <sub>S1S2</sub> = 1 A	9	16	23		
		V <sub>GS</sub> = 4 V, I <sub>S1S2</sub> = 1 A	10	17	25		
	Static Source1 to Source2 On Resistance	V <sub>GS</sub> = 3.1 V, I <sub>S1S2</sub> = 1 A	11	19	28	mΩ	
		V <sub>GS</sub> = 2.5 V, I <sub>S1S2</sub> = 1 A	12	22	33		
		V <sub>GS</sub> = 4.5 V, I <sub>S1S2</sub> = 1 A,T <sub>J</sub> = 125 °C		24	36		
9 <sub>FS</sub>	Forward Transconductance	V <sub>S1S2</sub> = 5 V, I <sub>S1S2</sub> = 1 A		4.5		S	

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 42.V. V 0.V	1140	1515	pF
C <sub>oss</sub>	Output Capacitance	V <sub>S1S2</sub> = 12 V, V <sub>GS</sub> = 0 V, f = 1 MHz	136	220	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 101112	129	205	pF

#### **Switching Characteristics**

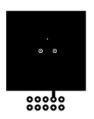
t <sub>d(on)</sub>	Turn-On Delay Time		9.5	19	ns
t <sub>r</sub>	Rise Time	V <sub>S1S2</sub> = 12 V, I <sub>S1S2</sub> = 1 A,	12	22	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$	37	59	ns
t <sub>f</sub>	Fall Time		16	33	ns
$Q_g$	Total Gate Charge	V 40 V 1 4 A	12	17	nC
$Q_{gs}$	Gate to Source1 Gate Charge	$V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$	1.6		nC
$Q_{gd}$	Gate to Source2 "Miller" Charge	vG1S1 - 4.5 v, vG2S2 = 0 v	3.7		nC

#### Source1 to Source2 Diode Characteristics

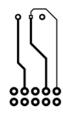
I <sub>fss</sub>	Maximum Continuous Source1 to Source2 Diode Forward Current				1	Α
V <sub>fss</sub>	Source1 to Source2 Diode Forward Voltage	$V_{G1S1} = 0 \text{ V, } V_{G2}$ $I_{fss} = 1 \text{ A}$	S2 = 4.5 V, (Note 2)	0.7	1.2	V

#### Notes

1. R<sub>0,1A</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,1C</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 74 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 230 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 us, Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only protection against ESD. No gate overvoltage rating is implied.

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

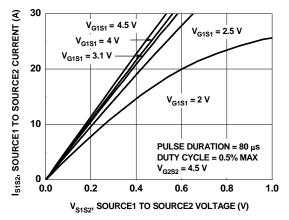


Figure 1. On-Region Characteristics

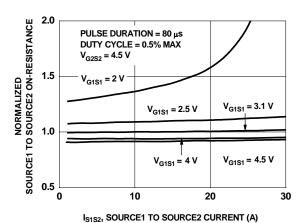


Figure 3. Normalized On-Resistance vs Source1 to Source2 Current and Gate Voltage

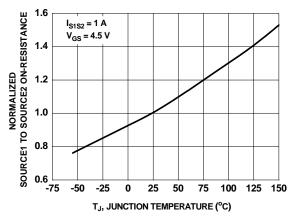


Figure 5. Normalized On Resistance vs Junction Temperature

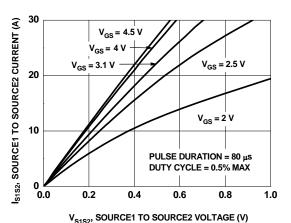


Figure 2. On-Region Characteristics

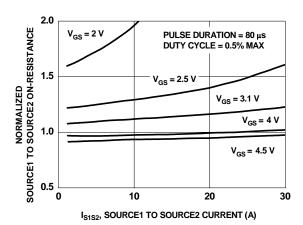


Figure 4. Normalized On-Resistance vs Source1 to Source2 Current and Gate Voltage

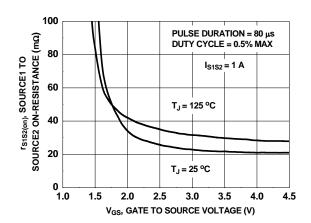


Figure 6. On Resistance vs Gate to Source Voltage

## Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

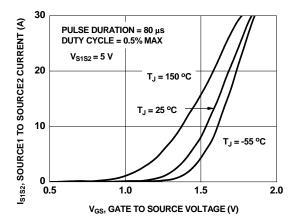


Figure 7. Transfer Characteristics

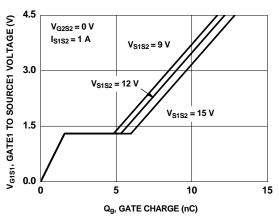


Figure 9. Gate Charge Characteristics

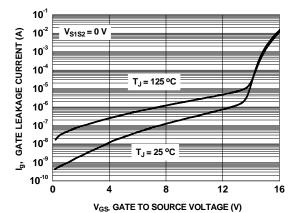
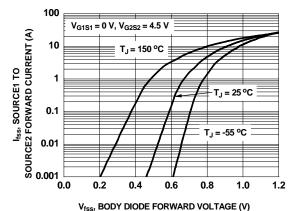


Figure 11. Gate Leakage Current vs Gate to Source Voltage



V<sub>fss</sub>, BODT DIODE FORWARD VOLTAGE (V)

Figure 8. Source1 to Source2 Diode Forward Voltage vs Source Current

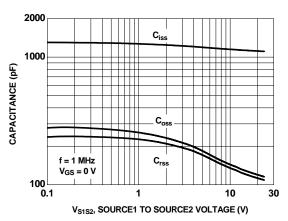
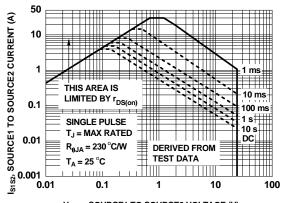


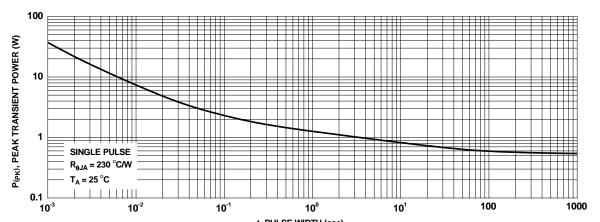
Figure 10. Capacitance vs Source1 to Source2 Voltage



 $V_{\text{S1S2}}$ , SOURCE1 TO SOURCE2 VOLTAGE (V)

Figure 12. Forward Bias Safe Operating Area

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted



t, PULSE WIDTH (sec)
Figure 13. Single Pulse Maximum Power Dissipation

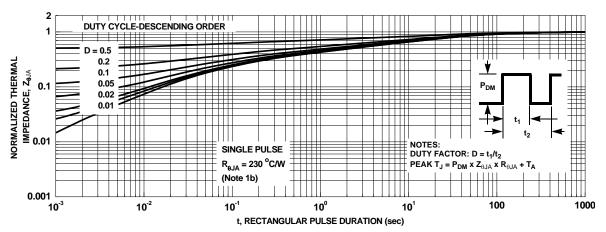


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

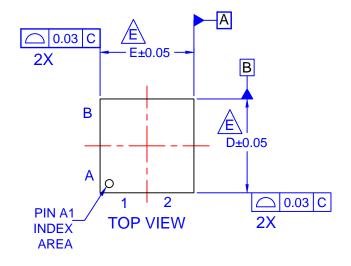
The following information applies to the WL-CSP package dimensions on the next page:

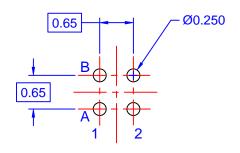
#### **Pin Definitions:**

Pin Name	G1	G2	S1	S2
Position	A2	B2	A1	B1

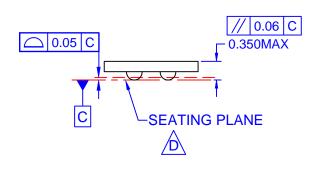
#### **Product Specific Dimensions:**

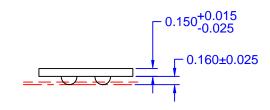
D	E	X	Υ
1.4 mm	1.6 mm	0.475 mm	0.375 mm





## LAND PATTERN RECOMMENDATION





#### **NOTES:**

- A. NO JEDEC REGISTRATION APPLIES.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCE

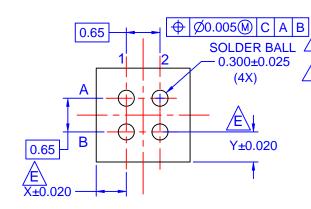
PER ASME Y14.5M, 1994.

D. DATUM C IS DEFINED BY THE SPHERICAL

CROWNS OF THE BALLS.

EN FOR DIMENSIONS D,E,X AND Y SEE PRODUCT DATA SHEET.

- F. FOR PIN-OUT ASSIGNMENT , REFER TO DATA SHEET.
- G. DRAWING NAME: MKT-UC004AJREV2.



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